

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KANEDA, NAOYA	
		Examiner Chriss S. Yoder, III	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,126,780 A	06-1992	Satou et al.	396/63
*	B	US-5,003,399	03-1991	Ishimaru et al.	348/361
*	C	US-6,130,994 A	10-2000	Maruyama, Atsushi	396/60
*	D	US-5,895,133 A	04-1999	Hirai, Isamu	396/238
*	E	US-4,975,726	12-1990	Kuga et al.	396/101
*	F	US-5,587,766 A	12-1996	Kawamura et al.	396/257
*	G	US-5,349,409 A	09-1994	Kawasaki et al.	396/87
*	H	US-5,010,357	04-1991	Misawa, Masayuki	396/72
*	I	US-2003/0011692 A1	01-2003	Shore et al.	348/240.3
*	J	US-2004/0028401 A1	02-2004	Nonaka, Osamu	396/121
*	K	US-2002/0097324 A1	07-2002	Onuki, Ichiro	348/208
*	L	US-2002/0171750 A1	11-2002	Kato, Masatake	348/345
*	M	US-6,130,994 A	10-2000	Maruyama, Atsushi	396/60

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.